

LIST OF ART CITED BY APPLICANT

(PTO-1449)

 ATTY. DOCKET NO.
YHK-0039

 APPLN. SERIAL NO.
09/514,250

APPLICANT(S)

Ho Young CHOI

 FILING DATE
February 28, 2000

 GROUP
2872

U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	*PATENT NO.	*ISSUE DATE	*INVENTOR NAME	CLASS	SUBCLASS	FILING DATE

U.S. PATENT APPLICATION PUBLICATIONS

EXAMINER'S INITIALS	*PATENT APPLN. PUB. NO.	*PUB. DATE	*APPLICANT	CLASS	SUBCLASS	FILING DATE

U.S. PATENT APPLICATIONS

EXAMINER'S INITIALS	*APPLN. NO.	*FILING DATE	*INVENTOR	CLASS	SUBCLASS	FILING DATE

FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No
	06-331941	12/2/94	JAPAN			X	
	04-361201	12/14/92	JAPAN			X	
	04-214516	8/5/92	JAPAN			X	
	57-108818	7/7/82	JAPAN			X	
	62-278520	12/3/87	JAPAN			X	
	03-276113	12/6/91	JAPAN			X	
	63-155432	6/28/88	JAPAN			X	
	60-247611	12/7/85	JAPAN			X	
	04-361201	12/2/94	JAPAN			X	
	06-331898	12/22/94	JAPAN			X	
	06-347700	12/2/94	JAPAN			X	
	06-331887	9/25/80	JAPAN			X	
	55-124114	2/6/96	JAPAN				X
	08-036131	4/7/88	JAPAN			X	
	63-077003	2/23/84	JAPAN			X	
	02-001109	1/5/90	JAPAN			X	
	59-033636	1/5/90	JAPAN			X	

OTHER ART (Including Author, Title, Date, Pertinent Pages, Publisher, Place of Publication, Etc.)

EXAMINER

DATE CONSIDERED

6/13/05

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

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U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	*PATENT NO.	*ISSUE DATE	*INVENTOR NAME	CLASS	SUBCLASS	FILING DATE
<i>me</i>	5,440,429	8/8/1995	Kim			
	5,272,540	12/21/1993	Hirata et al.			

U.S. PATENT APPLICATION PUBLICATIONS

	*PATENT APPLN. PUB. NO.	*PUB. DATE	*APPLICANT	CLASS	SUBCLASS	

U.S. PATENT APPLICATIONS

	*APPLN. NO.	*FILING DATE	*INVENTOR	CLASS	SUBCLASS	

FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No
<i>me</i>	WO 99/28779	6/10/99	WIPO			X	
<i>me</i>	EP 0 863 440 B1	4/23/2003	EUROPE			X	

OTHER ART (Including Author, Title, Date, Pertinent Pages, Publisher, Place of Publication, Etc.)

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6/13/05

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SHEET 1 OF 1

LIST OF PRIOR ART CITED BY
APPLICANT

(PTO-1449)

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H Y ung CHOI t al.

FILING DATE
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GROUP ART UNIT
2872


U.S. PATENT DOCUMENTS

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FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No
<i>Ch</i>	98-20576	6/25/98	Korea			X	

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)



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June 13/2005

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